

IMPULSE WINDING TESTER ST4030A



Transforming Motor Winding Testing

NEW	Quantification of				
	response waveforms				

Test rotor assembly status

Detect single-turn faults *Depends on measurement conditions

Improve quality by capturing accumulated turn fault data as feedback for upstream processes

CE

(optional upgrade for the ST4030A)

NEW DISCHARGE DETECTION UPGRADE

Detect partial discharges at high precision

Identify insulation defects (pseudo-shorts) between motor windings

Easily detect discharges

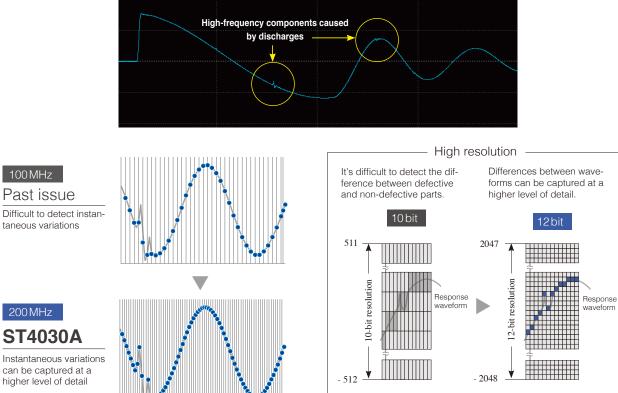
No need for peripheral equipment (discharge detection antenna, etc)

The new standard in winding testing

Detect defects that were impossible to detect in the past



Detect minuscule changes in response waveforms High-speed sampling × high resolution



Past issue Difficult to detect instan-



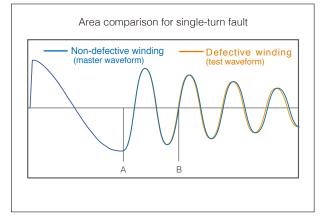
can be captured at a higher level of detail



Detect single-turn faults NEW Quantification of response waveforms

Conventional approach

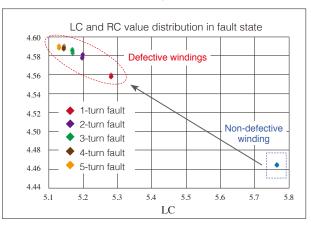
Area comparison based on waveforms



Pass/fail judgments are difficult when area differences do not exceed several percentage points.

Pass/fail judgments are made by calculating the difference in area between the master waveform and the test waveform for the interval specified by the A and B cursors.

New approach Quantification of response waveforms



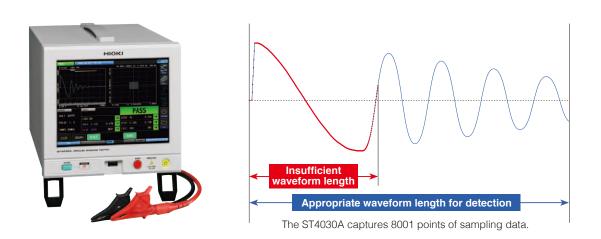
The distributions of values differ for defective and non-defective windings.

The new approach of using LC and RC values makes it possible to detect discrepancies between defective and non-defective windings, including when the differences between waveforms are too minuscule to detect using conventional means^{*}. Since detection thresholds can be clearly defined, the instrument can give provide a clear pass/fail decision.

*See "Testable inductance range" in the specifications on the last page for more information about motors for which detection is possible. Performance may depend on conditions. Please consult with your local Hioki distributor for a test demonstration prior to purchase.

Ample sampling data for proper detection Capture minuscule variations in response waveforms

However, since the ST4030A supports a large number of sampling points, the instrument can capture waveforms of sufficient length to support detection, even when sampling at 200 MHz.

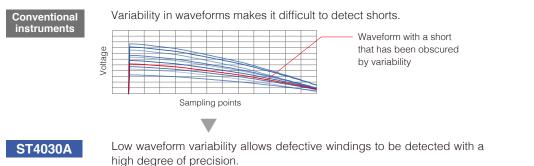


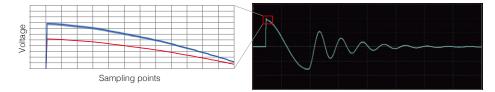
Improved applied voltage reproducibility

Detect defective parts with a high degree of repeatability

The ST4030A can detect defective parts with a high degree of precision thanks to low variability in the applied voltage it generates. In addition, differences between instruments when testing the same workpiece are slight, so you can continue to use master workpiece data even after one instrument is swapped out for another.

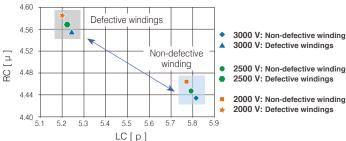






Reduced damage thanks to lower applied voltages

LC and RC values can be used to distinguish between defective and non-defective parts, without regard to the magnitude of the applied voltage. As a result, the applied voltage can be lowered, reducing damage to workpieces. The distributions of values differ even when the applied voltage is reduced, allowing the instrument to distinguish between defective and non-defective windings.



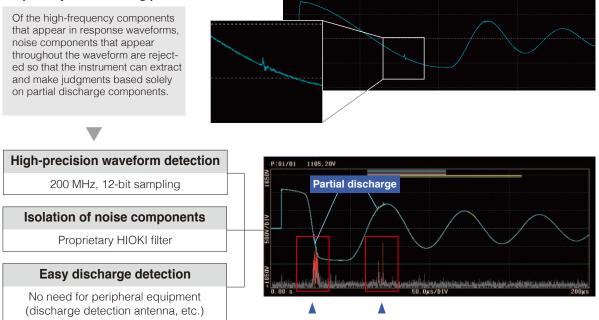
Optional upgrade for the ST4030A

NEW DISCHARGE DETECTION UPGRADE ST9000

Detect pseudo-shorts with a high degree of precision

By detecting minuscule partial discharges that are obscured by noise, the ST9000 makes it possible to detect insulation defects (pseudo-shorts) between motor windings.

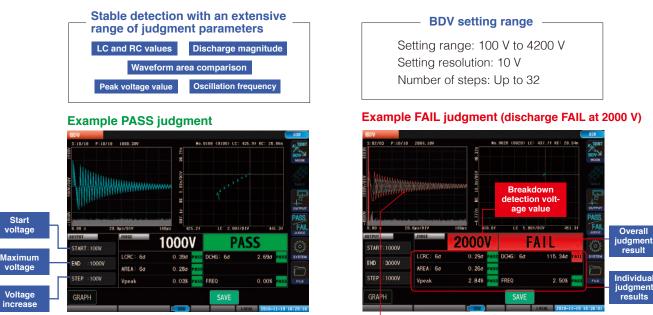
Proprietary Hioki filtering process



High-frequency discharge components are isolated by a proprietary Hioki filtering process.

Insulation breakdown voltage testing (Break Down Voltage)

The ST4030A also provides functionality for performing insulation breakdown voltage testing, which is required by various standards. An impulse test is performed while the voltage applied to the workpiece is gradually increased, and the insulation breakdown voltage is evaluated based on factors such as the response waveform's LC and RC values, the amount of discharge, and the waveform area.



If all judgments yielded a PASS result, testing continues to the maximum voltage.

If any of the judgments yields a FAIL result, the insulation is con-

sidered to have started to break down, and testing is halted at that point. The breakdown voltage waveform is shown in red.

Testing after rotor assembly

Once the rotor has been attached to the motor's stator, the stray capacitance between the rotor and stator will vary depending on the position at which the rotor was attached. This variation in stray capacitance means that the response waveform obtained during impulse testing varies, preventing use of the conventional waveform comparison method.

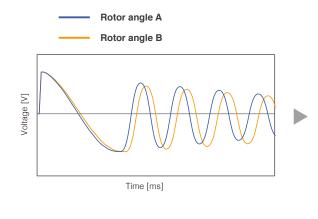
Although the LC and RC values used to quantify response waveforms also vary due to variations in those waveforms, the distributions of those values vary for defective and non-defective parts. Consequently, impulse testing can be performed after the rotor has been installed as long as defective and nondefective part judgment areas have been created.

Conventional waveform detection

Clear judgment standards cannot be defined due to differences in the response waveforms depending on the position and angle at which the rotor has been attached.

Variations in the voltage waveform when the rotor is rotated (simplified illustration)

Since the waveform varies depending on the locations at which rotor angles A and B occur, it is difficult to determine a standard to use to compare the waveforms.



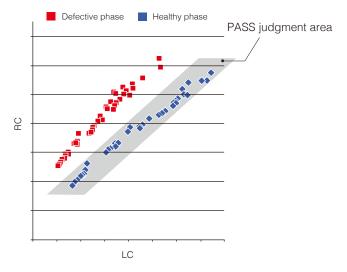
Numerical judgment using LC and RC values

HIOKI

If the non-defective part area is set using healthy phases, impulse testing can be performed following rotor assembly.

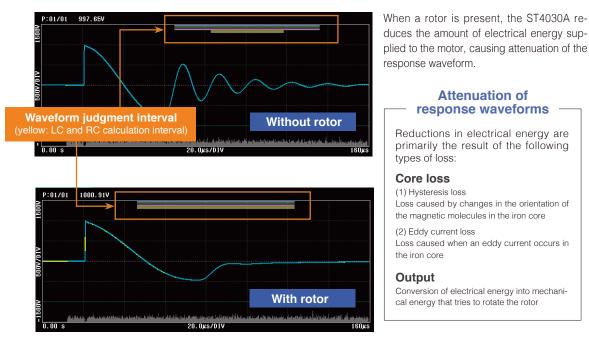
Distribution of LC and RC values when the rotor is rotated (at 50 points)

When LC and RC values are sampled while rotating the rotor, the distribution for defective phases differs from the distribution for healthy phases.



Accommodating differences in response waveform caused by motor characteristics

When testing a motor whose response waveform exhibits reduced resonance due to rotor core loss, the ST4030A automatically adjusts the judgment interval so that evaluations can be made over an interval with high voltage amplitude.

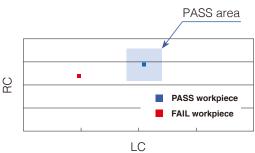


As long as the response waveforms for defective and non-defective motors differ, even if they are attenuated, the motors can be tested.

Improve parts quality by using quantified test results as feedback for upstream processes Quantitatively manage testing by quantifying response waveforms

Clarify judgment standard values

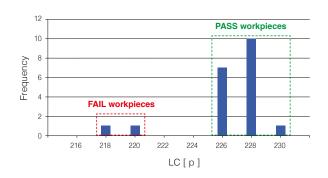
Clearly determine judgment standards based on numerical data for defective and non-defective workpieces. This information provides a basis for understanding how much the two can differ.



Use test results to manage manufacturing quality

Utilize statistical quality control techniques and accumulate statistical data to estimate when winding defects will occur so as to properly take steps to prevent such issues.

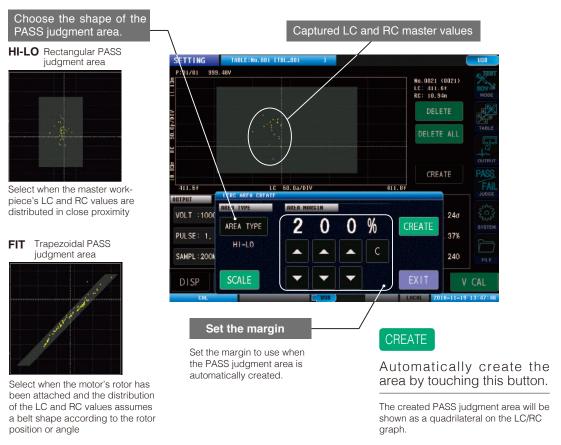
	Workpiece	LC [p]	RC [µ]	
	1	228	4.21	1
	2	227	4.22	
	3	226	4.22	
	4	228	4.23	
	5	227	4.22	
	6	226	4.21	
	7	227	4.23	
	8	225	4.22	
-	0	219	6.51	
	17	227	4.22	
	18	228	4.21	
	19	218	6.52	
	20	229	4.23	



Automatic configuration of the PASS judgment area

To make PASS and FAIL judgments, capture master LC and RC values from a known-good master workpiece.

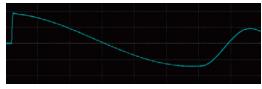
The ST4030A will automatically create a PASS judgment area based on those values.



Automatic configuration of the waveform capture range

The oscillation frequency of response waveforms varies with the type of workpiece. To allow a sufficient amount of waveform data to be used in LC/RC value calculation and waveform judgment, the sampling frequency and sampling data count are automatically adjusted so as to optimize the waveform capture range.

Workpiece A (low oscillation frequency)



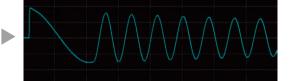
The captured waveform length is inadequate due to the response waveform's low oscillation frequency. The sampling frequency needs to be decreased.

Optimizing the waveform capture range

Workpiece B (high oscillation frequency)



An unnecessary amount of waveforms is being captured due to the response waveform's high oscillation frequency. Either the sampling frequency needs to be increased, or the sampling data count needs to be decreased. Waveform length after optimization using automatic adjustment

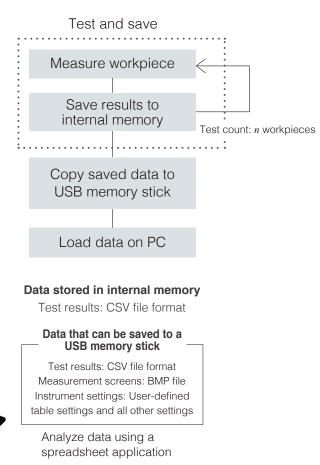


Functionality for recording and utilizing quantified test results Easily analyze test results on a computer



The ST4030A can save the results of up to 1000 tests in its internal memory. You can then copy that data to a USB memory stick, open the measurement data using a spreadsheet application, and use it to analyze variability and manage testing data.





Support for PLC and computer programming Build testing lines quickly

EXT. I/O test

Verify whether signals output from the external control terminal (EXT. I/O) are being properly output and whether input signals are being properly read.

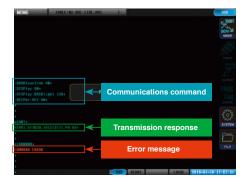


I/O OUT: The signal is output (turned on) from the I/O output pin with the name of the selected button.

I/O IN: The names of signals being input (turned on) are shown in green. Signals for which no input is being received are grayed out.

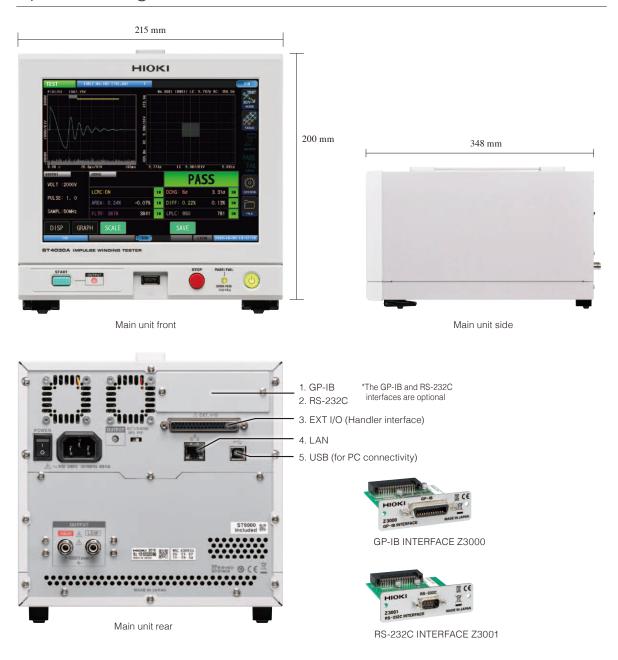
Communications monitor

Since you can display communications and query responses on the screen, you can build a testing line while checking the status of instrument operation in real time.



Commands are shown on the communications monitor in different colors to simplify the process of verifying proper operation.

Ideal for embedding in winding inspection systems Space-saving Half-rack Size



Extensive range of interfaces

Interfaces

The ST4030A can be controlled from a computer using communications commands sent via its USB, LAN, GP-IB, or RS-232C interface.

|--|

Connector	RJ-45 connector
Electrical specifications	IEEE802.3 compliant
Transmission method	10BASE-T/ 100BASE-TX/ 1000BASE-T Auto detected
Protocol	TCP/IP

GP-IB (optional)

Reference standard	IEEE-488.2		
Functional specifications	SH1, AH1, T6, L4, SR1, RL1, PP0, DC1, DT1, C0		
Device address	0 to 30		

USB (for PC connectivity)

Connector	USB Type B receptacle
Electrical specifications	USB2.0 (Full Speed/High Speed)

RS-232C (optional)

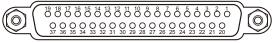
Connector	D-sub 9-pin male connector
Communication method	Full duplex
Synchronization method	Start stop synchronization
Flow control	Software (XON/XOFF control)
Transmission speed	9600, 19200, 38400, 57600 bps

EXT. I/O

The EXT. I/O interface allows you to output signals such as the measurement complete signal (EOM) and the judgment results signal (PASS/FAIL) to an external device and to control the instrument based on input such as a START signal from an external device.

Connectors

	D- sub 37-pin	
Connectors to use (unit side)	Female connector with #4-40 inch screws	
	DC-37P-ULR (solder type)	
Compliant connectors	DCSP-JB37PR (pressure weld type)	
	Japan Aviation Electronics Industry, Ltd.	



Input signals

	-	
Pin	Pin name	Description
1	START	The instrument starts testing at the START sig- nal's ON edge.
20	STOP	The instrument stops testing when it detects the ON edge of the STOP signal during testing.
3	INTERLOCK	If the instrument's interlock setting is enabled, the interlock state is canceled while the INTER- LOCK signal is ON.
4 to 7, 22 to 25	TBL0 to 7	Selects the table number in which switchable test conditions have been saved.

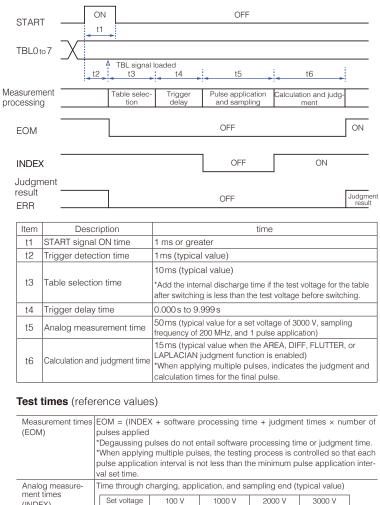
Output signals

output	Signalo	
Pin	Pin name	Description
29	INDEX	Indicates that analog measurement (pulse ap- plication and sampling) has ended. When this signal changes from OFF to ON, the probes can be placed in the open state.
28	EOM	This signal is output when testing is complete. The judgment results and ERR signals are re- freshed once the EOM signal is output.
10	ERR	This signal is output when a measurement error such as an open error or hardware error occurs.
18	PASS	This signal is output when the overall judgment result is PASS.
37	FAIL	This signal is output when the overall judgment result is FAIL.
11 to 13 30 to 32	OUT_XXX	These signals are output when a judgment func- tion generates an OUT judgment.
16, 17,35	OUT0 to 2	These signals can be used as general-purpose output. The output signal can be controlled us- ing the :IO:OUTPut command.

Insulated power source output

Pin	Pin name	NPN/PNP switch settings		
		NPN	PNP	
8	ISO_5V	Insulated power source +5 V	Insulated power source -5 V	
9, 27	ISO_COM	Insulated power source common	Insulated power source common	

Example of measurement timing



(INDEX)	Set voltage	100 V	1000 V	2000 V	3000 V	I	
· /	INDEX time	30 ms	30 ms	40 ms	50 ms	I	
Software process- ing time	Software processing time covering data transfers, etc.(typical value), Processing time: 10 ms 'S/s: 200 MHz, DISP: THIN						
Judgment time	Processing time	d (typical value	e)				
	Judgment	Processir	ng time				
	AREA*1	1m	s				
	DIFF*1	1m	s				
	FLTR*1	1m	S *1 I	dament area: 1	E00 pt		
	LAPC*1	1m		loulation interv			
	LC·RC*2	100 r			l with sampling	speed	
	DISCHARGE*3	75 m	ns of i	200 MHz: 8001	pt	•	

Electrical specifications

•		1
Input signals	Input type	Photocoupler-isolated non-voltage contact input (with current sink/source output support)
	Input ON	Residual voltage of 1 V or less; input ON current of 4 mA (reference values)
	Input OFF	OPEN (breaking current of 100 µA or less)
Output signals	Output type	Photocoupler-isolated open-drain output (non-polar)
	Maximum load voltage	DC 30 V
	Maximum load current	50 mA/ch
	Residual voltage	1 V or less (load current of 50 mA) / 0.5 V or less (load current of 10 mA)
Internally isolated power supply	Output voltage	Sink output support: +5.0 V ±0.8V; source output support: -5.0 V ±0.8 V
	Maximum output current	100 mA
	Insulation	Floating from protective ground potential and measurement circuit
	Insulation rating	Terminal-to-ground voltage of 50 V DC, 30 V AC rms, 42.4 V AC peak or less

Specifications (Accuracy guaranteed for 1 year, Post-adjustment accuracy guaranteed for 1 year)

Applied voltage	100 V to 4200 V (res	olution set in 10 V steps)		
Testable inductance range	10 µH to 100 mH			
Sampling speed	200 MHz / 100 MHz / 50 MHz / 20 MHz /10 MHz			
Sampling resolution	12 bit			
Voltage detection accuracy	DC accuracy: ±5% of setting, AC band: 100 kHz, ±1 dB Accuracy guarantee conditions: 23°C ±5°C, 80% RH or less			
Number of samples	1001 to 8001 points (set in 1000 point steps)			
	The same impulse voltage is applied to a master workpiece and the workpiece under test, and a PASS/FAIL judgment is made by comparing the shapes, LC and RC values, and discharge component magnitudes of the respective response waveforms.			
	LC/RC value judg- ment	LC/RC value judgment (LCRC AREA)		
Judgment method	Waveform judgment	Waveform area comparison judgment (AREA) Waveform differential area comparison judgment (DIFF-AREA) Waveform flutter detection judgment (FLUTTER) Waveform second derivative detection judgment (LAPLACIAN)		
	Discharge detection (With ST9000)	Discharge detection (DISCHARGE)		
Insulation breakdown voltage test- ing mode	The workpiece is subjected to impulse testing while gradually raising the applied voltage to determine the voltage at which the insulation breaks down. Waveform area judgment, discharge judgment, and LC/RC valu judgment are used to judge insulation breakdown.			
Number of test condition tables	255 (test condition se	ttings, detection condition settings, master waveforms)		
Test duration	Approx. 60 ms (reference value when tester is configured for 3000 V, 1 pulse, detection off)			
Display	Touch screen display:	8.4-inch SVGA color TFT LCD (800 × 600 dots)		
Safety functionality	Key lock, interlock, d	ouble-action design (to prevent erroneous operation when starting testing)		

General specifications

*Maximum applied energy: Approx. 88 mJ

Operating environment	Use indoors at an elevation of 2,000 m or less in an environment with a maximum pollution level of 2
Operating temperature and humidity range	0°C to 40°C (32°F to 104°F), 80% RH or less (no condensation)
Storage temperature and humidity	-10°C to 50°C (14°F to 122°F), 80% RH or less (no condensation)
Standards compliance	Safety: EN 61010, EMC: EN 61326 Class A
Power supply	AC100 V to 240V, 50 Hz/60 Hz
External interface	Standard equipment: EXT. I/O, USB host (memory stick), USB device (for communications), LAN Options: RS-232C (Z3001), GP-IB (Z3000)
Dimensions	Approx. 215 mm (8.46 in) W × 200 mm (7.87 in) H × 348 mm (13.7 in) D (excluding protrusions)
Mass	Approx. 6.7 kg (236.3 oz)
Accessories	Power cord, instruction manual, application disc, operating precautions

Model: IMPULSE WINDING TESTER ST4030A

Options

CLIP TYPE LEAD L2250

Maximum rated voltage: 3300 V AC

peak, 1.5 m (4.92 ft) length

Model No. (Order Code) ST4030A

Additional function options

DISCHARGE DETECTION UPGRADE ST9000

The Discharge Detection Upgrade ST9000 is a factory option for the Impulse Winding Tester ST4030A. Please specify at the time of order.

Caution: Effect of cable parasitic components

The oscillation waveform varies with the length of the cable. Please contact your Hioki distributor concerning availability of special-order cables whose capacitance values fall within the acceptable range.

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UNPROCESSED LEAD CABLE L2252

Maximum rated voltage: 4200 V AC

peak, 2 m (6.56 ft) length